



■ Modular, expandable system

Surge voltage to 4.4 kV

■ EFT/Burst to 4.8 kV/1 MHz

■ POT to 16 A/260 VAC & DC

■ Easy to use 7" color touch screen

 DTA (Direct Test Access) provides fast standard test settings

Parameters can be changed while test is running

Wide range of optional test accessories The new NSG 3040 is an easy to use and convenient multifunction generator to simulate electromagnetic interference effects for immunity testing in conformity with international, national and in-house standards including the latest IEC/EN standards. It completes the multifunction generator family with the new Teseq design philosophy,

This innovative design is based on modular architecture to provide a versatile system, that can be configured for basic testing needs and expanded to meet the needs of sophisticated test laboratories.

The NSG 3040 system is designed to fulfill conducted EMC test requirements for CE mark testing and includes generally combination wave, EFT pulses and PQT. Extensive expansion capabilities enable the system to be configured for a much broader range of applications.

The well proven and unique "Master-Slave" concept technology, enables individual pulse modules to be calibrated separately with the calibration data and correction factors stored on the slave controller. New modules are simply installed with no need to return the entire system for calibration.

Using state-of-the-art components, the self-contained modules set new standards with respect to switching and phase accuracy and exceed the existing standards' requirements.

The integration of a high quality and large 7" color touch panel display with superb contrast makes the control of the NSG 3040 easy. Depending on requirements, the inputs are supported by an integrated keyboard, or by using a wheel with additional keys for sensitivity adjustment. Furthermore to arrive at a conclusive result quickly and reliably in a development environment, a standardized test can be triggered with a few "clicks" using the integrated DTA function (Direct Test Access).

Each parameter's value is highly visible and all settings can be quickly selected and modified with the generously sized touch input buttons. A stylus is not necessary, and ramp functions are programmed quickly and easily. Multi-step test procedures can be created and their sequence or parameter values changed easily.

The selection of "Expert Mode" allows the user to make a manual parameter change with the wheel during a test – an effective and fast method for simply activating critical threshold values.

Firmware downloads can be performed quickly with the easily accessible SD memory card reader. Tests specified by the user will be saved completely. In the rare case that the storage space is not sufficient, the card can be replaced by a commercially available SD memory card and existing test files can be easily copied onto the larger SD card.

The NSG 3040 has an Ethernet port for external control from a PC. The Windows software simplifies test programming and allows compiling of complex test sequences with various types of tests. Test reports can be generated during the test operation allowing the operator to enter observations as the test progresses thus increasing the efficiency of long-term tests.



The generator covers following tests:

Combination wave pulse 1, 2/50 - 8/20 µs (Hybrid-Surge pulse)

Pulse conforms to IEC/EN 61000-4-5

| Parameter | Value |
|--------------------------------|---|
| Pulse voltage (open circuit): | ±200 V to 4.4 kV (in 1 V steps) |
| Pulse current (short circuit): | ±100 A to 2.2 kA |
| Impedance: | 2/12 Ω |
| Polarity: | positive / negative / alternate |
| Pulse repetition: | 10 s, up to 600 s (in 1 s steps) |
| Test duration: | 1 to 9999 pulses, continuous |
| Phase synchronization: | asynchronous, synchronous 0 to 359° (in 1° steps) |
| Coupling: | external / internal |

Burst (EFT) 5/50 ns

Pulse conforms to IEC/EN 61000-4-4

| Parameter | Value |
|------------------------|---|
| Pulse amplitude: | ±200 V to 4.8 kV (in 1 V steps) - open circuit |
| | ± 100 V to 2.4 kV (50 Ω matching system) |
| Burst frequency: | 100 Hz to 1000 kHz |
| Polarity: | positive / negative / alternate |
| Repetition time: | 1 ms to 4200 s (70 min) |
| Burst time: | 1 μs to 1999 s, single pulse, continuous |
| Test duration: | 1 s to 1000 h |
| Phase synchronization: | asynchronous, synchronous 0 to 359° (in 1° steps) |
| Coupling: | external / internal |



Dips & drops

conforms to IEC/EN 61000-4-11

| Value |
|---|
| From EUT voltage input to 0 V, 0% |
| depending on model (VAR 650x) |
| 0, 40, 70, 80% (INA 650x) |
| 500 A (at 230 V) |
| 1 to 5 μs (100 Ω load) |
| 20 µs to 1999 s, 1 to 99'999 cycles |
| 1 s to 70'000 min, 1 to 99'999 events, continuous |
| 40 μs to 35 min, 1 to 99'999 cycles |
| asynchronous, synchronous 0 to 359° (in 1° steps) |
| |

Variation test (with VAR 65xx only)

conforms to IEC/EN 61000-4-11

| Parameter | Value |
|----------------------------|---|
| Uvar with optional variac: | 0 to 265 V (in 1 V steps), 0 to 115% (in 1% steps) |
| Repetition time: | 1 ms to 35 min, 1 to 99'999 cycles |
| Test duration: | 1 ms to 5 s, 1 to 250 cycles (50 Hz); |
| | 1 to 300 cycles (60 Hz), abrupt |
| Repetition time: | 10 ms to 10 s; 1 to 250 cycles (50 Hz), 1 to 300 cycles (60 Hz) |
| Test duration: | 1 s to 99'999 min, 1 to 99'999 events, continuous |
| Phase synchronization: | asynchronous, synchronous 0 to 359° (in 1° steps) |

Pulsed magnetic field in conjunction with INA 753 and INA 701 or 702

conforms to IEC/EN 61000-4-9

| Parameter | Value |
|------------------------|---|
| Field: | 1 to 1200 A/m (in 1 A/m steps) |
| Polarity: | positive / negative / alternate |
| Repetition time: | 5 s to 10 min (in 1 s steps) |
| Impedance: | 2 Ω |
| Coil factor | 0.01 to 50.00 |
| Test duration: | 1 to 9'999 pulses; continuous |
| Phase synchronization: | asynchronous, synchronous 0 to 359° (in 1° steps) |



Power magnetic field in conjunction with MFO 6501 / MFO 6502 and INA 70x conforms to IEC/EN 61000-4-8

| Field: | 1 to max. 40 A/m (in 1 A/m steps) |
|----------------|-----------------------------------|
| Frequency: | 50/60 Hz |
| Coil factor: | 0.01 to 99.99 |
| Test duration: | 1 to 9'999 pulses, continuous |

Internal coupling network

| Parameter | Value |
|-------------------------|--|
| Decoupling attenuation: | Remanent pulse 15% max. |
| | Mains side crosstalk 15% max. |
| Mains decoupling: | 1.5 mH 0% + 35% |
| Connections: | Back panel: |
| | EUT supply: Harting connector |
| | Additional ground connector |
| | Instrument supply 230/115 VAC |
| | Front panel: |
| | EUT connector IEC 320 |
| | HV coaxial |
| EUT. | Connector surge high & low |
| EUT supply: | 1-phase |
| EUT VAC: | 24 to 260 Vrms, 50/60 Hz (phase - neutral), 400 Hz max. |
| EUT VDC: | 0 to 260 VDC |
| EUT current | 1 x 16 Arms continuous (temperature controlled) 1 x 25 Arms for 15 min |
| EFT (Burst) | Standard coupling all lines to ref ground (GND) |
| | IEC/EN 61000-4-4 I. N. PF |
| | L, N, PE ⇒ ref GND Any lines and combinations to ref GND: |
| | Arry lines and combinations to ref GND. |
| | N ⇒ ref GND |
| | PE ⇒ ref GND |
| | L, N ⇒ ref GND |
| | L, PE ⇒ ref GND |
| | N, PE ⇒ ref GND |
| PQT: | Dips & drops to phase L |
| | |



| Dimensions/weight | |
|------------------------------|---|
| Dimensions NSG 3040: | 449 (17.7") x 226 (8.9"; 5 HU) x 565 mm (22.2"), W x H x D |
| Weight NSG 3040: | approx. 25 kg (55 lbs) |
| | |
| Options | |
| CDN 8014/8015 | Capacitive coupling clamp for burst |
| CDN 163 | Burst coupling network 100 A per phase (coupling all to ref ground) |
| CDN 117/118 | Coupling networks for signal-/data lines (surge) |
| CAS 3025 | Burst/EFT verification set |
| MD 200 | Voltage differential probe 7 kV |
| MD 300 | Current probe 5 kA |
| | |
| Accessories for IEC/EN 61000 | 0-4-11 |
| INA 6501 | Manual step transformer, 16 AAC, 0/40/70/80% |
| INA 6502 | Automatic step transformer, 16 AAC, 0/40/70/80% |
| VAR 6501 | Automatic variable transformer, 7.5 A |
| VAR 6502 | Automatic variable transformer, 2 x 16 A |
| VAR 6503 | Manual variable transformer, 7.5 A |
| | |
| Accessories for IEC/EN 61000 | 0-4-8/-4-9 |
| MFO 6501 | Manual magnetic field option -4-8 |
| MFO 6502 | Automatic magnetic field option -4-8 |
| INA 701 | Magnetic field coil 1 x 1 m; with MFO max. 3.6 A/m -4-8; |
| | Surge* max. 1200 A/m -4-9 |
| INA 702 | Magnetic field coil 1 x 1 m, with MFO max. 40 A/m -4-8; |
| | Surge* max. 1200 A/m -4-9 |
| | *) Pulse shape adapter INA 753 needed to surge generator |
| INA 753 | Pulse shape adapter |
| | |

